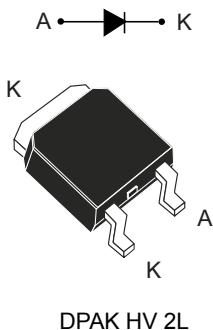


## 1200 V, 10 A, silicon carbide power Schottky diode



### Features

- No or negligible reverse recovery
- Switching behavior independent of temperature
- Robust high voltage periphery
- Operating  $T_j$  from -40 °C to 175 °C
- Low  $V_F$
- DPAK HV creepage distance (anode to cathode) = 3 mm min.
- ECOPACK2 compliant

### Applications

- EV Charging station
- Servers
- DC/DC
- PFC

### Description

This 10A, 1200V SiC diode is an ultra-high performance power Schottky diode. It is manufactured using a silicon carbide substrate. The wide band gap material allows the design of a Schottky diode structure with a 1200 V rating. Due to the Schottky construction, no recovery is shown at turn-off and ringing patterns are negligible. The minimal capacitive turn-off behavior is independent of temperature

Housed in DPAK HV, this diode is perfectly suited for a usage in PFC applications, in charging station, servers, DC/DC modules, easing the compliance to IEC-60664-1.

The **STPSC10H12B2-TR** will boost performances in hard switching conditions. Its high forward surge capability ensures good robustness during transient phases.

#### Product status link

[STPSC10H12B2-TR](#)

#### Product summary

$I_{F(AV)}$	10 A
$V_{RRM}$	1200 V
$T_j$ (max.)	175 °C
$V_F$ (typ.)	1.35 V

## 1 Characteristics

**Table 1.** Absolute ratings (limiting values at 25 °C, unless otherwise specified)

Symbol	Parameter		Value	Unit
V <sub>RRM</sub>	Repetitive peak reverse voltage ( $T_j = -40$ °C to +175 °C)		1200	V
I <sub>F(RMS)</sub>	Forward rms current		25	A
I <sub>F(AV)</sub>	Average forward current $\delta = 0.5$ , square wave		10	A
I <sub>FRM</sub>	Repetitive peak forward current		38	A
I <sub>FSM</sub>	Surge non repetitive forward current		71	A
			60	
T <sub>stg</sub>	Storage temperature range		-65 to +175	°C
T <sub>j</sub>	Operating junction temperature <sup>(1)</sup>		-40 to +175	°C

1.  $(dP_{tot}/dT_j) < (1/R_{th(j-a)})$  condition to avoid thermal runaway for a diode on its own heatsink.

**Table 2.** Thermal resistance parameters

Symbol	Parameter	Value		Unit
		Typ.	Max.	
R <sub>th(j-c)</sub>	Junction to case	0.65	0.9	°C/W

**Table 3.** Static electrical characteristics

Symbol	Parameter	Test conditions		Min.	Typ.	Max.	Unit
I <sub>R</sub> <sup>(1)</sup>	Reverse leakage current	T <sub>j</sub> = 25 °C	V <sub>R</sub> = V <sub>RRM</sub>	-	5	60	µA
		T <sub>j</sub> = 150 °C		-	30	400	
V <sub>F</sub> <sup>(2)</sup>	Forward voltage drop	T <sub>j</sub> = 25 °C	I <sub>F</sub> = 10 A	-	1.35	1.50	V
		T <sub>j</sub> = 150 °C		-	1.75	2.25	

1. Pulse test:  $t_p = 5$  ms,  $\delta < 2\%$

2. Pulse test:  $t_p = 500$  µs,  $\delta < 2\%$

To evaluate the conduction losses, use the following equation:

$$\bullet \quad P = 1.03 \times I_{F(AV)} + 0.122 \times I_{F(RMS)}^2$$

For more information, please refer to the following application notes related to the power losses:

- AN604: Calculation of conduction losses in a power rectifier
- AN4021: Calculation of reverse losses on a power diode

**Table 4. Dynamic electrical characteristics**

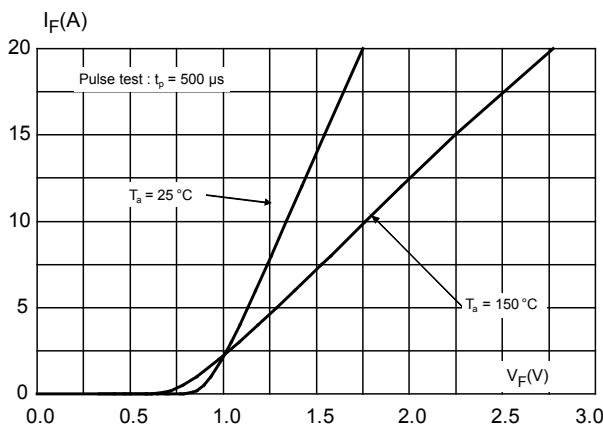
Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$Q_{Cj}$ <sup>(1)</sup>	Total capacitive charge	$V_R = 800 \text{ V}$	-	57	-	nC
$C_j$	Total capacitance	$V_R = 0 \text{ V}, T_c = 25 \text{ }^\circ\text{C}, F = 1 \text{ MHz}$	-	725	-	pF
		$V_R = 800 \text{ V}, T_c = 25 \text{ }^\circ\text{C}, F = 1 \text{ MHz}$	-	47	-	

1.

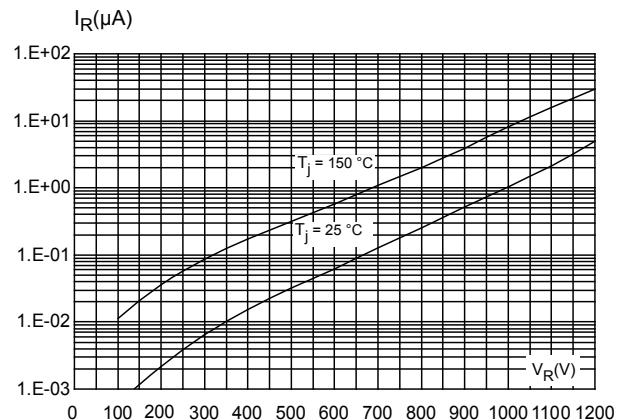
$$\text{Most accurate value for the capacitive charge: } Q_{Cj}(V_R) = \int_0^{V_R} C_j(V) dV$$

## 1.1 Characteristics (curves)

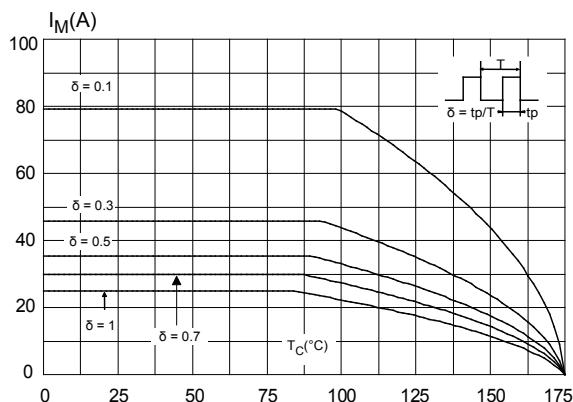
**Figure 1. Forward voltage drop versus forward current (typical values)**



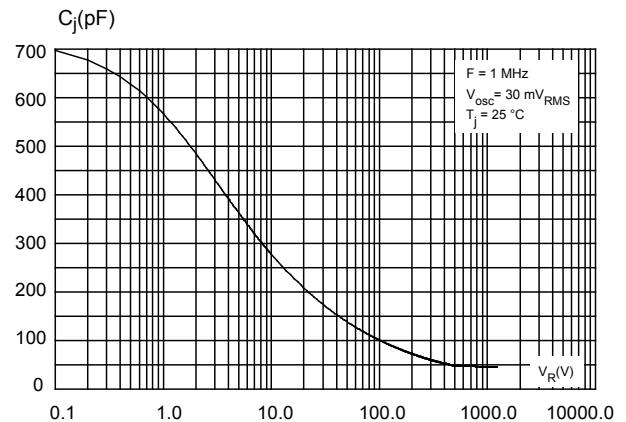
**Figure 2. Reverse leakage current versus reverse voltage applied (typical values)**



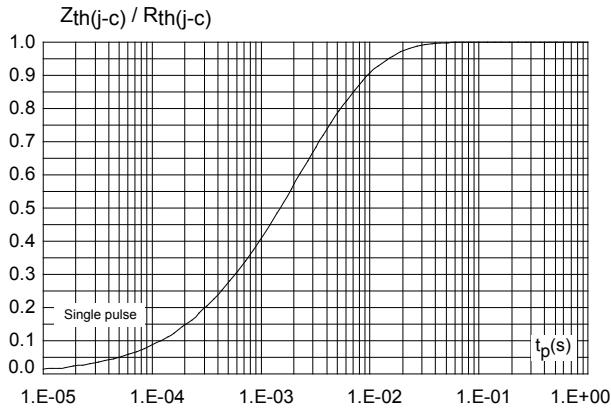
**Figure 3. Peak forward current versus case temperature**



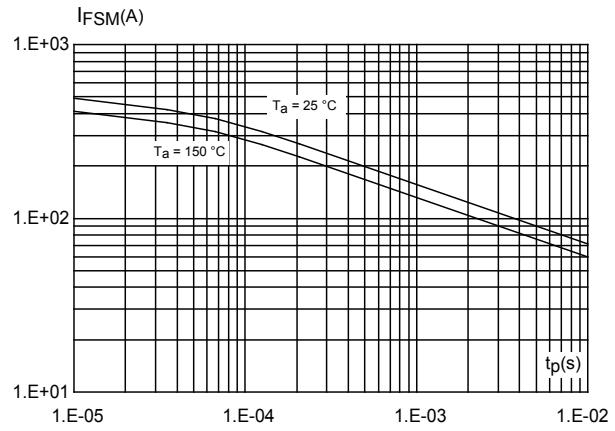
**Figure 4. Junction capacitance versus reverse voltage applied (typical values)**



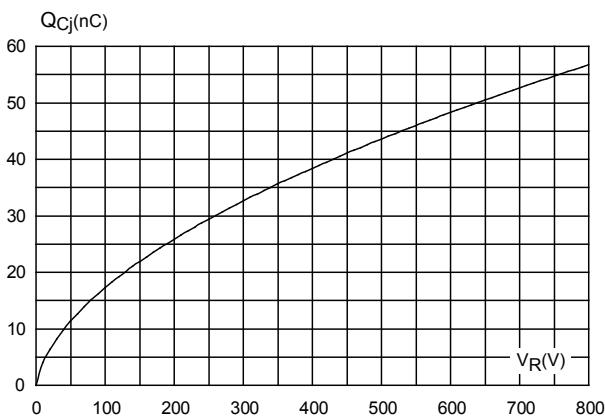
**Figure 5. Relative variation of thermal impedance junction to case versus pulse duration**



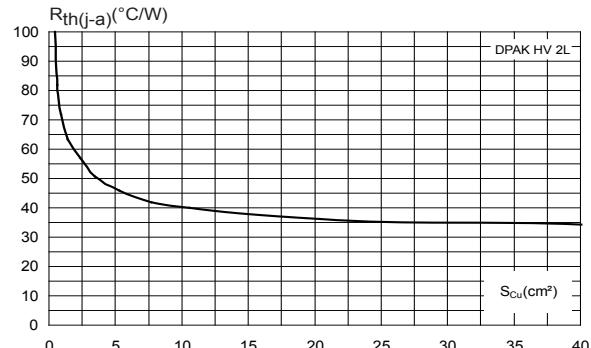
**Figure 6. Non-repetitive peak surge forward current versus pulse duration (sinusoidal waveform)**



**Figure 7. Total capacitive charges versus reverse voltage applied (typical values)**



**Figure 8. Thermal resistance junction to ambient versus copper surface under tab on epoxy printed board FR4,  $e_{Cu} = 35 \mu m$  (typical values)**



## 2 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

### 2.1 DPAK HV 2L package information

- Epoxy meets UL 94,V0
- Cooling method: by conduction (C)

Figure 9. DPAK HV 2L package outline

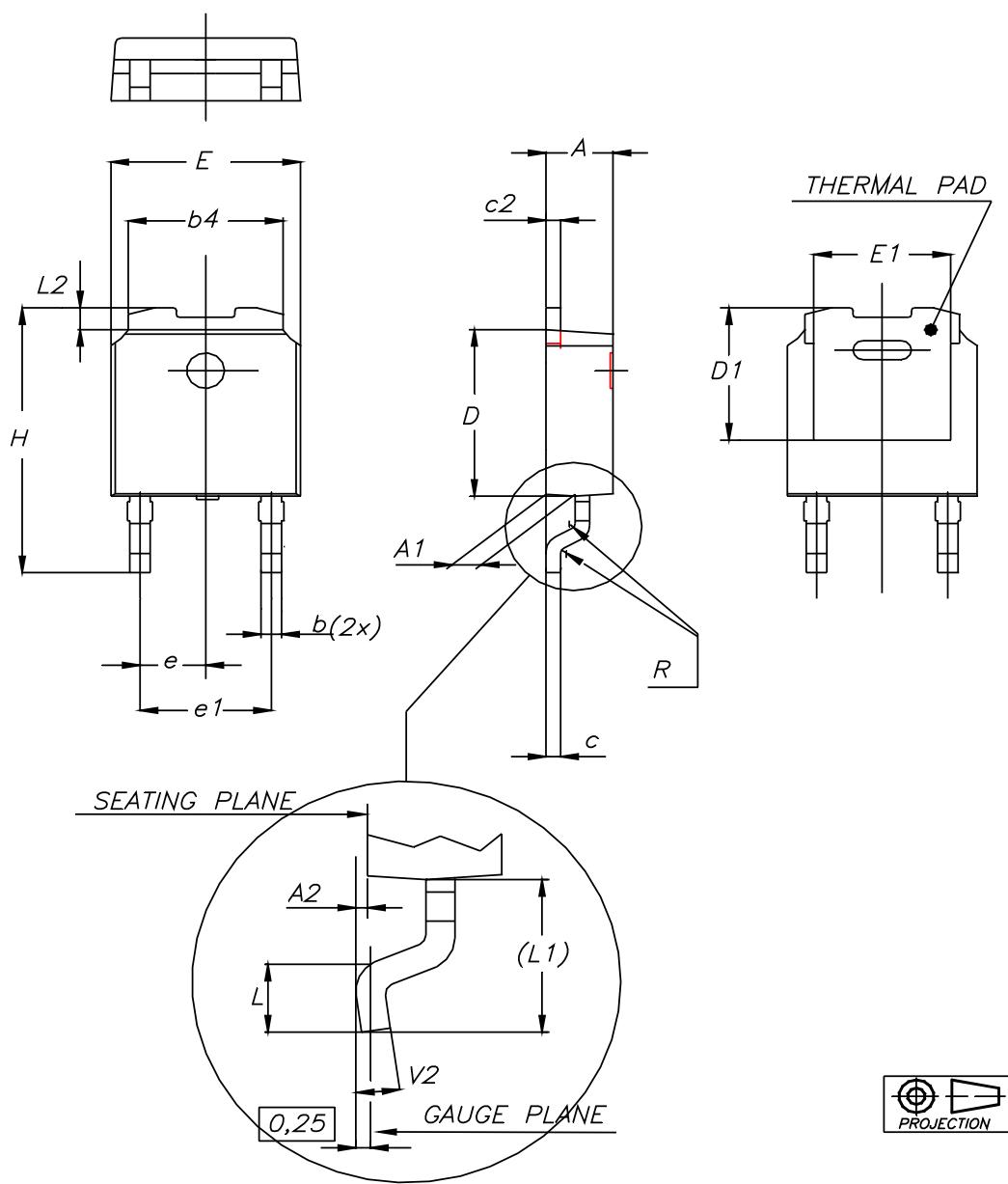
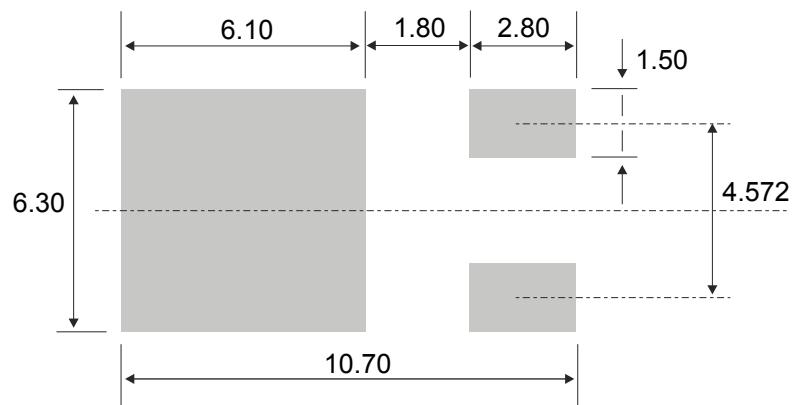


Table 5. DPAK HV 2L package mechanical data

Ref.	Dimensions					
	Millimeters			Inches (for reference only)		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	2.20	2.29	2.40	0.086	0.090	0.095
A1	0.90		1.10	0.035		0.044
A2	0.03		0.23	0.001		0.010
b	0.64	0.76	0.90	0.025	0.030	0.036
b4	5.20	5.10	5.40	0.204	0.201	0.213
c	0.45		0.60	0.017		0.024
c2	0.48		0.60	0.018		0.024
D	6.00		6.20	0.236		0.245
D1	4.60	4.70	4.80	0.181	0.185	0.189
E	6.40		6.60	0.251		0.260
E1	4.95	5.10	5.25	0.194	0.201	0.207
e	2.16	2.28	2.40	0.085	0.090	0.095
e1	4.40		4.60	0.173		0.182
H	9.35		10.10	0.368		0.398
L	1.00		1.50	0.039		0.060
L1	2.60	2.80	3.00	0.102	0.110	0.119
L2	0.65	0.80	0.95	0.025	0.031	0.038
V2	0°		8°	0°		8°

Figure 10. Footprint (dimensions in mm)



### 2.1.1 Creepage distance between Anode and Cathode

**Table 6. Creepage distance between anode and cathode**

Symbol	Parameter	Value	Unit
Cd <sub>A-K</sub>	Minimum creepage distance between A and K	DPAK HV	3.0 mm

Note: DPAK HV creepage distance (anode to cathode) = 0.3 mm min. (refer to IEC 60664-1)

### 3 Ordering information

**Table 7. Ordering information**

Order code	Marking	Package	Weight	Base qty.	Delivery mode
STPSC10H12B2-TR	PSC10 H12	DPAK HV	0.350 g	2500	Tape and reel

## Revision history

**Table 8. Document revision history**

Date	Revision	Changes
31-Aug-2020	1	First issue.

**IMPORTANT NOTICE – PLEASE READ CAREFULLY**

STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST's terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers' products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. For additional information about ST trademarks, please refer to [www.st.com/trademarks](http://www.st.com/trademarks). All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2020 STMicroelectronics – All rights reserved